

1 **Small-volume Lu-Hf and U-Pb isotope determination of complex zircons by**
2 **solution and laser ablation MC-ICP-MS**

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12
13 **Abstract**

14
15 There is an increasing need for solution and laser ablation analysis methods suited to the
16 determination of the Lu-Hf and U-Pb isotope signatures of small volumes of zircon
17 corresponding to sub-nanogram amounts of Hf. This study presents a reduced-volume
18 laser ablation protocol with consecutive U-Pb and Lu-Hf isotopic analyses resulting in a
19 total pit depth of 18 μm using a 25 μm laser ablation spot. This results in excavation of
20 ~ 40 ng of zircon, equating to ~ 0.4 ng of Hf and uncertainties $\sim 1 \epsilon_{\text{Hf}}$ (2s). The laser
21 technique presented here is ideally suited to complex, finely zoned zircons for which
22 drilling to depth would intersect different zones. The possibility of reducing the total laser
23 ablation pit depth to ~ 10 μm is demonstrated by decreasing the integration time for Hf
24 isotope analysis without serious compromise of the uncertainty. Furthermore, the
25 capability to determine the Hf isotope composition of the same amount of Hf using solution
26 MC-ICP-MS is also demonstrated, as is the suitability of analyzing solutions not subject
27 to Hf-HREE separation. For both solution and laser ablation methods, this study
28 investigates possible methods of Yb interference correction, the potential for matrix
29 effects, and the accurate determination of $^{176}\text{Lu}/^{177}\text{Hf}$. Using the approaches described
30 here, acceptable uncertainty levels are achieved to resolve complexity at the level of

31 25x18 μm (diameter x depth), and therefore this method has the potential to yield
32 geologically meaningful results for rocks containing complexly-zoned zircons.

33

34 **1. Introduction**

35 Zircon Lu-Hf and U-Pb isotopic datasets are ubiquitous in modern geologic studies
36 and are produced using either high-precision dissolution-based techniques or lower-
37 precision microbeam methods. Zircon Lu-Hf solution analyses are often determined for
38 whole grain dissolutions, which can result in the homogenization of distinct isotopic zones,
39 thereby representing mixtures without geologic significance. A proper evaluation of
40 complex zircons via solution methods necessitates micro-sampling (e.g. Hawkins and
41 Bowring, 1997), yet the targeted domains are often of insufficient size to obtain
42 meaningful levels of precision with standard solution-based measurement procedures.
43 Conventional techniques for laser ablation analyses typically sample $\sim 2\text{-}3$ ng Hf and
44 conventional solution analyses >5 ng Hf, often on the order of ~ 25 ng. A cylindrical pit of
45 zircon 30 μm in diameter and depth yields approximately $1\text{-}2$ ng of Hf, depending on Hf
46 concentration; for <1 ng Hf, conventional analytical methods result in uncertainties great
47 enough to effectively prohibit discrimination of variation. The amount of material required
48 for Hf isotope analysis by laser ablation multi-collector inductively coupled plasma mass
49 spectrometry (LA-MC-ICP-MS) typically results in Lu-Hf laser ablation spots of $\sim 35\text{-}50$
50 μm in diameter and depths of $30\text{-}40$ μm ; these parameters are sufficiently large as to
51 potentially sample multiple distinct zones with depth in highly-zoned zircon. A benefit of
52 this approach is that the time series of the analyses enable inspection of variations of
53 $^{176}\text{Lu}/^{177}\text{Hf}$ and $^{176}\text{Hf}/^{177}\text{Hf}$ with depth. One consequence of conventional ‘high-volume’
54 Lu-Hf ablation, however, is that the U-Pb age information, usually obtained via SIMS or
55 LA-ICP-MS on an adjacent spot, may become decoupled from the Lu-Hf isotope
56 information. The mismatch of these two isotope datasets can result in an initial ϵ_{Hf}
57 signature calculated with the wrong age (see discussion in Amelin et al., 2000). To combat
58 this, two techniques are commonly used—coupled Pb-Hf isotope analysis, where the
59 $^{207}\text{Pb}/^{206}\text{Pb}$ is periodically measured during a Hf isotope analysis (e.g. Kemp et al., 2010)
60 or laser ablation split stream (LASS) (Yuan et al., 2008; Fisher et al., 2014), where two
61 mass spectrometers simultaneously analyze the divided ablation particle stream. Pit

62 volumes remain high for both methods, with total pit depths of ~40 μm or more (Fisher et
63 al. 2014; Ibanez et al., 2015; Kemp et al., 2010), so unless these zones can be clearly
64 discriminated, the potential remains for sampling and integrating multiple zones with
65 depth.

66 To determine compositions of complexly zoned zircons, small-volume solution and
67 laser ablation analysis methods are required. Previous studies have focused on the
68 minimization of sample volumes for Lu-Hf solution analysis of zircon (Bast et al., 2015;
69 d'Abzac et al., 2016). With the ultimate goal of low-volume analysis of meteorite samples,
70 Bast et al (2015) successfully analyzed chemically-isolated Hf solutions with sub-
71 nanogram amounts using a Neptune Plus MC-ICP-MS equipped with a Jet sample cone
72 and $10^{12} \Omega$ resistors to maximize Hf measurement precision. They obtained 1.5-4.0 ϵ_{Hf}
73 precision (2 sigma, after propagation for systematic uncertainties) for analyses of 0.5 ng
74 of Hf. However, chemical separation of Hf potentially increases blank, is more time-
75 consuming and requires separate analysis of $^{176}\text{Lu}/^{177}\text{Hf}$ for age correction, thereby
76 limiting the achievable Hf isotope precision by removing material. To maximize efficiency
77 (maintain the maximum amount of sample and lowest blank) therefore requires the
78 analysis of zircon solutions without chemical separation (hereafter referred to as 'neat').
79 D'Abzac et al. (2016) investigated the effect of eliminating the chemical separation
80 process for small-volume zircon and baddeleyite solutions on the resultant Lu-Hf isotopic
81 data. Using a Neptune Plus MC-ICP-MS and a Jet sample cone, they analyzed <0.2 ng
82 of Hf, achieving ~2 ϵ_{Hf} (2SE) precision (excluding propagation for systematic
83 uncertainties).

84 In this study, we aimed to optimize low-volume analysis techniques for samples
85 containing sub-nanogram amounts of Hf for both solution and laser ablation analysis of
86 zircons bearing complexity on the ~20 μm scale. To maintain precision levels around 1
87 ϵ_{Hf} (2s), a level considered appropriate for most geologic interpretations, analysis of this
88 small amount of material requires a reconsideration of the sample introduction and data
89 processing methods. To build upon previous small-volume Hf method-development
90 studies, we focused on solution measurements with small (100 μL) total uptake to
91 optimize the signal to noise ratio (SNR) and permit precise simultaneous measurement
92 of $^{176}\text{Lu}/^{177}\text{Hf}$. Furthermore, we contribute methods to match this level of precision with

93 laser ablation analysis. To maximize use of the available sample, we forgo traditional Hf-
94 HREE separation chemistry (so that $^{176}\text{Lu}/^{177}\text{Hf}$ can be determined simultaneously with
95 Hf isotopes). To achieve this, a number of questions need to be addressed, including: Are
96 the Hf isotope data of zircon samples accurate when analyzed as neat solutions? Under
97 these conditions, is the Yb isobaric interference correction robust, especially at relatively
98 high HREE/Hf? Is the blank contribution significant when analyzing such small amounts
99 of material? Are special analysis conditions required to obtain robust data while promoting
100 Hf efficiency? How does running neat solutions affect the accuracy and quantification of
101 Lu/Hf? To address these and other questions, a series of tests were performed using
102 zircon reference materials and natural sample sets for solution and laser ablation
103 analysis.

104

105 **2. Analytical methods**

106 To investigate the need for chemical separation of Hf with sub-nanogram sized
107 samples, we determined the Hf isotope composition of a 91500 zircon solution with and
108 without Hf separation chemistry. This solution, as well as laser ablation data for 91500,
109 also provided a dataset for the assessment of the stability and accuracy of the $^{176}\text{Lu}/^{177}\text{Hf}$
110 determination. A solution of the Mud Tank zircon was used to test the effect of matrix load
111 on the robustness of the Yb correction. The JMC475 Hf isotope reference solution was
112 used throughout the study and two natural sample sets demonstrate the precision
113 obtained by these methods. The sample materials are described below. The blank
114 contribution of the different sample processing and introduction methods was assessed.

115

116 2.1 Reference materials and samples

117 **Reference zircon 91500** is from Kuehl Lake, Ontario, and the $^{206}\text{Pb}/^{238}\text{U}$ age has
118 been determined to be 1065.4 ± 0.3 Ma (Wiedenbeck et al., 1995). The $^{176}\text{Hf}/^{177}\text{Hf}$ is
119 0.282306 ± 8 and the $^{176}\text{Lu}/^{177}\text{Hf}$ is 0.000311 (Woodhead and Hergt, 2005; Blichert-Toft,
120 2008). Because the $^{176}\text{Lu}/^{177}\text{Hf}$ was not presented in these studies with an associated
121 uncertainty, we normalized our data to 0.00030 ± 3 (2s), which, based on previous laser
122 ablation experiments, is considered as an accurate representation of the natural Lu/Hf
123 variation (i.e. 10%) in zircon 91500. The 91500 standard solution used in this study was

124 prepared by a bulk dissolution in HF that was subsequently evaporated and redissolved
125 in 2% HNO₃. For neat solutions, no further modifications were made to the sample. For
126 the comparison of neat and separated solutions, an aliquot of this solution was processed
127 through Hf-HREE-Zr separation chemistry modified after Münker et al., (2001)
128 (Supplementary Table 1). Zircon 91500 was used as the primary reference material for
129 the solution and laser Lu-Hf isotopic analyses of natural samples in this study, as well as
130 for experiments to determine the effect of amount of matrix on the measured ¹⁷⁶Lu/¹⁷⁷Hf
131 and its uncertainty. In the experiment conducted to evaluate the viability of running neat
132 versus purified zircon Hf solutions, 91500 served as a secondary reference material.

133 In this study, the **JMC475 Hf solution** was used as a reference material for Hf
134 isotopes (assuming ¹⁷⁶Hf/¹⁷⁷Hf = 0.282160; Nowell et al., 1998) with variable additions
135 ('dopants') of Lu and/or Yb to evaluate oxide formation in the plasma and to evaluate
136 isobaric interference corrections on mass 176. Dopant levels targeted a total Yb/Hf of
137 ~0.25 and Lu/Hf of ~0.005 to 0.25 to evaluate the accuracy of our interference corrections.
138 JMC475 was used as a primary reference material in experimental evaluations of neat
139 versus purified Hf solutions of zircon 91500.

140 **Mud Tank zircon** (731.65 ± 0.49 Ma, ²⁰⁶Pb/²³⁸U age, 95% confidence,
141 MSWD=1.9, n=6, Horstwood et al., 2016) is a widely-used U-Pb reference material
142 sourced from a carbonatite in the Northern Territory, Australia (Black and Gulson, 1978).
143 This sample has fairly homogeneous ¹⁷⁶Hf/¹⁷⁷Hf, 0.282507 ± 6, but a high degree of
144 heterogeneity of ¹⁷⁶Lu/¹⁷⁷Hf, with a typical value ~0.000042, though there is a small zircon
145 sub-population of this sample for which ¹⁷⁶Lu/¹⁷⁷Hf is much higher, ~0.00014 (Woodhead
146 and Hergt, 2005). The Mud Tank solutions used in this study are washes from the U-Pb
147 separation chemistry of two large Mud Tank zircon grains. One of these grains has a
148 typical ¹⁷⁶Lu/¹⁷⁷Hf of ~0.00001 (z2) and the other has a higher ¹⁷⁶Lu/¹⁷⁷Hf of ~0.0001 (z1).
149 Aside from wash collection from U-Pb columns in 3N HCl, evaporation, and dilution, no
150 further chemical separations were made. Therefore, these solutions are effectively 'neat'
151 solutions excluding U, Pb, and Si. Aliquots of these Mud Tank solutions were doped with
152 a known amount of Lu to evaluate matrix effects on the Lu-Hf ratio and with Yb to evaluate
153 the effect of varying Yb/Hf on two different methods of Yb isobaric interference correction.
154 In this study, Mud Tank zircon serves as a secondary reference material.

155 **Zimb-95-24** - This sample is a zircon separate from a modern river sand collected
156 in the Sebakwe river in the Midlands of Zimbabwe and is used to demonstrate the
157 applicability of the successive low-volume U-Pb and Lu-Hf laser ablation methods.

158 **Granitic zircon samples** - Zircon grains from a granite suite were analyzed for
159 Lu-Hf isotopes by solution methods. The zircons were subsampled before chemical
160 abrasion and were processed as part of a regional geological CA-ID-TIMS U-Pb study,
161 which will form the focus of another paper but the analytical merits of the data will be
162 discussed here.

163

164 2.2 Isotopic analysis

165 Zircon Lu-Hf isotopic analyses were performed on a Thermo Scientific Neptune
166 Plus MC-ICP-MS at the Natural Environment Research Council Isotope Geosciences
167 Laboratory (NIGL) of the British Geological Survey (BGS) in Nottingham, United Kingdom.
168 Cup configuration and analytical conditions for Lu-Hf isotopic analyses (solution and
169 laser) are listed in Table 1. A Jet sample cone was used to maximize Hf transmission
170 efficiency, however, instrument tuning conditions were optimized for low oxide production
171 in the plasma (see Section 4.4 for discussion).

172 **Dissolved zircon solutions** (various pre-treatments outlined in Section 2.1) and
173 the JMC475 Hf solution were redissolved in 100 μL of 2% HNO_3 solution with 0.1M HCl
174 (to stabilize Lu) and 0.1 M HF (to stabilize Hf). Samples and reference materials were
175 introduced using a Cetac Technologies Aridus II nebulizer with a PFA-50 nebulizer tip
176 operating at a flow rate of $\sim 43 \mu\text{L} / \text{min}$. Nitrogen was added at 5 ml/min to optimize Hf
177 ionization efficiency, decrease oxide formation, and restrict non-linear mass dependent
178 Hf fractionation (Hu et al., 2012).

179 To maximize precision and the efficient use of sample, we used a sample aliquot
180 with higher concentration and minimized volume to maximize the SNR of the analysis.
181 This required changing the sample introduction method to minimize or avoid the
182 introduction of air between aspiration of wash and aspiration of the sample, which
183 destabilizes the plasma, induces inter-element (Lu/Hf) fractionation, impacts isobaric
184 interference corrections, and causes spiking of the background from the desolvation
185 system. The requirements for introduction were developed manually and later automated

186 to allow efficient analysis. For both manual and automated runs, washout between
187 samples was ~15 minutes in length and the instrument electronic baseline was
188 determined during these intervals. For manual analysis, the uptake probe of the nebulizer
189 was placed into a 1.5 ml micro-centrifuge tube containing 300 μL of blank acid. One
190 hundred seconds of stable washout were collected as background until $<50 \mu\text{L}$ of blank
191 acid remained, at which point the sample was injected and mixed with the remaining wash
192 acid. In this way, a stable ion signal was quickly reached, resulting in a greater fraction of
193 the sample signal to be utilized in data processing.

194 For automated analysis, a Teledyne Cetac Technologies MVX-7100 low-volume
195 autosampler was used to inject 100 μL of sample into the desolvating nebulizer in
196 alternation with 100 μL acid blanks. This system uses syringe pumps to load a sample
197 onto a loop of tubing while the rest of the system is being flushed by a wash acid, before
198 switching a valve to push the sample into the introduction system. The sample is isolated
199 from surrounding blank acid by small air-locks (10-25 μL) on either side.

200 Reference materials JMC475, 91500, and Mud Tank were run at varying
201 concentrations (3 - 40 ppb) to determine reproducibility of Hf isotopic measurements at
202 varying total nanograms (0.3 - 4 ng) Hf analyzed. Natural zircon sample solutions were
203 run at 1-40 ppb Hf (0.1 - 4 ng). The stability of inter-element isotopic ratios was monitored
204 and analyses or portions of analyses with significant variation, indicating destabilization
205 of the flow injection rate and/or background spiking from the desolvator, were excluded
206 from the final interpretation. Total procedural blanks for Hf-HREE-Zr separation chemistry
207 were run using a dynamic collection protocol with a secondary electron multiplier to
208 determine Hf concentration and Hf isotopic compositions (presented in Table 1 and
209 conditions reported in Table 2). All solution analyses were acquired in time resolved
210 analysis (TRA) mode using a 0.262 sec integration period, acquiring many thousands of
211 cycles, and the data were imported into the Lolite (Paton et al., 2011) data processing
212 package for reduction and interrogation.

213 For **laser ablation analyses**, zircons were mounted in epoxy, polished to
214 equatorial sections, and imaged via cathodoluminescence (CL) (Fig. 1) on the BGS FEI
215 Quanta 600 scanning electron microscope (SEM). Ablation spot selection was guided by
216 CL images and transmitted light to distinguish between distinct zones and to avoid

217 inclusions and cracks. The mounts were washed in 2% HNO₃, ethanol, and water before
218 analysis. Laser ablation pit depths were determined using the SEM in secondary electron
219 mode. Observations were made on a tilted stage at 40.2 degrees (see Supplementary
220 Figure 1) while in variable pressure mode (P ~ 0.45 torr). The accuracy of the pit depth
221 measurements is estimated to be better than 5%.

222 Zirconium was ablated using an ESI (New Wave Research Division) UP193FX
223 excimer laser system fitted with a custom-built, low-volume cell (Horstwood et al., 2003).
224 Typical Hf signals were ~6-10 V of ¹⁸⁰Hf. Instrument operation parameters are in Table 2.
225 The mass spectrometer was tuned using Yb and Lu-doped JMC475 Hf solutions
226 introduced using the Aridus II desolvating nebulizer, with the goal of maximizing Hf
227 detection efficiency while minimizing oxide production. Unknowns were run in blocks of
228 10-12 bracketed by measurements of reference zircons 91500, Mud Tank, and Plešovice.

229 Zirconium Lu-Hf isotopic data were reduced in Lolite (Paton et al., 2011) using 91500
230 as the primary reference material (weighted mean ¹⁷⁶Hf/¹⁷⁷Hf = 0.282298 ± 2, MSWD =
231 1.5, n = 75, and ¹⁷⁶Lu/¹⁷⁷Hf = 0.000319 ± 18, 2SD). The principles of the uncertainty
232 propagation protocol shown in Horstwood et al., (2016) are here applied to Hf isotope
233 data. Reported uncertainties for ¹⁷⁶Hf/¹⁷⁷Hf and ¹⁷⁶Lu/¹⁷⁷Hf are analytical uncertainties
234 combined in quadrature with excess variance of the primary reference (zircon 91500) on
235 a per session basis. Hf stable isotope ratios (¹⁷⁸Hf/¹⁷⁷Hf and ¹⁸⁰Hf/¹⁷⁷Hf) were monitored
236 for data quality.

237 Two separate collector configurations for laser ablation U-Pb analysis were used
238 in this study (A and B, Table 3)—the standard collector configuration used for U-Pb
239 isotopic analysis at NIGL as well as an amended configuration to permit Faraday
240 collection of the ²⁰⁶Pb beam for high-Pb samples. U-Pb isotopic data were collected in
241 two sessions (session 1: configuration A, session 2: configuration B) using a Nu
242 Instruments Nu-Plasma HR MC-ICP-MS. Analytical set-up and instrument operation
243 parameters are in Table 3. Zirconium material was ablated using the same laser ablation
244 system as for the Lu-Hf measurements. Laser conditions and spot sizes varied depending
245 on the expected U (and thus ²⁰⁶Pb) concentration of the zircons and are listed in
246 Supplementary Table 6. The large age range encompassed by the detrital sample (~270-
247 3300 Ma) required the use of both collector configurations to optimize the precision of our

248 measurements while sampling the smallest possible volume. The samples that were
249 youngest and/or low-U were analyzed using configuration A with a 25 μm spot and a
250 fluence of 2.7 J/cm² (Fig. 2a). The same spot parameters resulted in a signal too large to
251 accurately measure using ion counters for samples that were older or high-U, so smaller
252 spot sizes of 15 μm (Fig. 2b and 2c) were applied using configuration B. A ²³⁵U- ²⁰³Tl-
253 ²⁰⁵Tl solution was co-aspirated into the plasma in the same way as that detailed in
254 Horstwood et al. (2003) via a Nu Instruments DSN-100 desolvating nebulizer. Data were
255 collected in time-resolved analysis mode using the Nu Plasma HR instrument software,
256 with normalization and uncertainty propagation utilizing an in-house Excel spreadsheet.
257 A common Pb correction was not required. GJ-1 was used as a primary reference material
258 with the reference values defined in Horstwood et al. (2016). For the detrital zircon sample
259 analyzed in this study (Zimb-95-24), reported data point uncertainties include propagation
260 for systematic components following Horstwood et al. (2016). Calculated ages and plots
261 were generated with Isoplot (Ludwig, 2003) and using decay constants from Jaffey et al.
262 (1971) and ²³⁸U/²³⁵U of 137.818 (Hiess et al., 2012). Discordance was calculated using
263 ²⁰⁷Pb/²⁰⁶Pb and ²⁰⁶Pb/²³⁸U dates for zircons >1 Gyr and ²⁰⁶Pb/²³⁸U and ²⁰⁷Pb/²³⁵U dates
264 for zircons < 1 Gyr.

265

266 2.3 Yb correction for solution and laser work

267 For all analyses, the correction of ¹⁷⁶Yb interference on ¹⁷⁶Hf was assessed in two
268 separate ways. The ¹⁷⁶Yb isobar was evaluated using Yb mass bias determined using: 1)
269 direct measurement of ¹⁷²Yb/¹⁷³Yb, and 2) by pre-calibration of the Yb mass bias to Hf
270 mass bias (see Nowell & Parrish, 2001). The first method is the traditional approach used
271 in most Lu-Hf studies, but the second method is ideal for low-Yb samples. In this method,
272 the Yb mass bias is determined using calibrated ¹⁷⁶Yb/¹⁷³Yb, which is determined at the
273 start of each session by analyzing Yb-doped JMC475 solutions. This value was found to
274 be extremely stable at 0.79435-0.79455 across all analytical sessions using the low oxide
275 tuning conditions employed. The assessment and validity of both correction methods are
276 discussed in Section 4.2. Equations 1 and 2 outline how the ¹⁷⁶Yb isobar is determined in
277 method 1 (utilizing ¹⁷²Yb/¹⁷³Yb = 1.35274 and ¹⁷⁶Yb/¹⁷³Yb = 0.7962; Chu et al., 2002).

278 Equations 3 and 4 outline how $^{176}\text{Yb}/^{173}\text{Yb}$ is pre-calibrated in method 2 and how this is
 279 applied to determine the magnitude of the ^{176}Yb isobar.

280

$$281 \quad \beta_{\text{Yb}, \text{method 1}} = \frac{\ln\left(\frac{^{173}\text{Yb}/^{172}\text{Yb}_{\text{reference}}}{^{173}\text{Yb}/^{172}\text{Yb}_{\text{measured}}}\right)}{\ln\left(\frac{M_{173}}{M_{172}}\right)} \quad \text{(equation 1)}$$

282

$$283 \quad ^{176}\text{Yb}_{\text{calculated}, \text{method 1}} = ^{173}\text{Yb}_{\text{measured}} \times \left(\frac{^{176}\text{Yb}}{^{173}\text{Yb}}\right)_{\text{reference}} \times \left(\frac{M_{173}}{M_{176}}\right)^{\beta_{\text{Yb}}} \quad \text{(equation 2)}$$

284

$$285 \quad \frac{^{176}\text{Yb}}{^{173}\text{Yb}}_{\text{method 2}} = \frac{\left(\frac{^{176}\text{Yb}}{^{173}\text{Yb}}\right)_{\text{calibrated}}}{\left(\frac{M_{176}\text{Yb}}{M_{173}\text{Yb}}\right)^{\beta_{\text{Hf}}}} \quad \text{(equation 3)}$$

286

$$287 \quad ^{176}\text{Yb}_{\text{calculated}, \text{method 2}} = ^{173}\text{Yb}_{\text{measured}} \times \left(\frac{^{176}\text{Yb}}{^{173}\text{Yb}}\right)_{\text{method 2}} \quad \text{(equation 4)}$$

288

289 2.4 Lu/Hf normalization for solution and laser work

290 For solution analyses of zircons, corrections were applied to the $^{176}\text{Lu}/^{177}\text{Hf}$ to
 291 account for inter-element fractionation in the plasma and induced bias due to amount of
 292 matrix. The uncertainty of the $^{176}\text{Lu}/^{177}\text{Hf}$ for these analyses is fully propagated to include
 293 excess variance from: 1) the in-session primary reference material, 2) matrix bias
 294 correlated with concentration, and 3) the long-term excess variance of $^{176}\text{Lu}/^{177}\text{Hf}$
 295 measurements for zircon 91500 in sessions where it was not self-normalized. The matrix
 296 bias corrections of the $^{176}\text{Lu}/^{177}\text{Hf}$ and its uncertainty are outlined in Section 4.3.

297 Zircon $^{176}\text{Lu}/^{177}\text{Hf}$ laser ablation data were normalized and corrected for drift using
 298 zircon 91500 as the primary reference material. The laser $^{176}\text{Lu}/^{177}\text{Hf}$ uncertainties are
 299 dominated by the excess variance, $\pm 3.1\%$ (2s) derived from zircon 91500. Population
 300 statistics suggest that this is an over-propagation and likely relates to the 5-10%
 301 heterogeneity of Lu/Hf exhibited by 91500 which, in our experience, is the most
 302 homogeneous zircon reference material for Lu/Hf. For future studies, until a more
 303 homogeneous material is documented, NIST610 could be used to quantify session
 304 excess variance for Lu/Hf and the data could still be normalized to 91500 as a matrix-

305 matched reference material. Recent experiments by the authors indicate that more
306 appropriate Lu/Hf population statistics (MSWD ~ 1) are achieved when propagated in this
307 way, suggesting that this is a suitable way of quantifying this uncertainty.

308

309 2.5 Procedural blank size and isotopic composition

310 For the Hf separation chemistry, the amount of Hf blank introduced during the
311 separation procedure was quantified to determine its impact on the Lu-Hf isotopic
312 composition of small samples. The data collection routine required peak jumping across
313 the ion counter and the $^{176}\text{Hf}/^{177}\text{Hf}$ was determined in two ways; one with ^{176}Hf on an ion
314 counter and ^{177}Hf on a Faraday detector, and a second collection method with both
315 masses (^{176}Hf and ^{177}Hf) collected by ion counters. The resultant Hf blanks were ~ 1-2 pg
316 Hf (Table 1), even with the extensive Zr-Hf wash steps of our separation procedure
317 (Supplementary Table 1). Furthermore, the $^{176}\text{Hf}/^{177}\text{Hf}$ composition of our procedural
318 blank was 0.2820 ± 0.0009 (MSWD=0.22, n=3, IC-IC, Table 2), which is similar to the
319 bulk Earth today and a value for which the blank correction of >0.3 ng Hf samples is minor
320 or negligible.

321 For automated solution analyses, the blank averaged 4 pg total Hf. For manual
322 solution analyses, the typical background measurement was ~20 fg Hf, i.e. 200 times less
323 than the blank using the MVX-7100. These amounts are insignificant in comparison to the
324 amount of Hf (0.1-4.1 ng) in the natural zircon solutions that were processed. Continued
325 development work using the MVX-7100ul workstation is expected to decrease this blank
326 contribution significantly.

327

328 **3. Experimental results**

329

330 3.1 Low-volume solution Lu-Hf analyses

331 The long-term reproducibility of the reference materials used in this study are
332 included in Supplementary Table 2 (and are not self-normalized). The full solution dataset
333 is presented in Supplementary Table 3. The granitic zircon solution Lu-Hf results are
334 presented in Table 4. The samples have been anonymized. Subsampled zircon domains
335 that survived chemical abrasion yielded 0.1 to 4.1 ng Hf. An analytical cut-off of 0.3 ng Hf

336 was selected when considering the data (see Fig. 3a-c and Section 4.1), however, data
337 for samples having <0.3 ng Hf are included in Table 4 for reference. A matrix bias was
338 noted (see Section 4.3) and a correction applied to the normalized $^{176}\text{Lu}/^{177}\text{Hf}$. The
339 sample $^{176}\text{Lu}/^{177}\text{Hf}$ ranged from 0.000499 to 0.004859 and the fully-propagated 2σ
340 uncertainty was <3% for samples containing >0.3 ng Hf. The largest Yb/Hf of the samples
341 was ~0.2, which is at the highest end of the range of terrestrial zircons. Figure 3a shows
342 the relationship between the $^{176}\text{Hf}/^{177}\text{Hf}$ measurement uncertainty and total ng of Hf
343 processed for these samples.

344 The long-term weighted mean of neat 91500 solutions before normalization was
345 0.282302 ± 3 (MSWD 2.6, n=32) and the $^{176}\text{Lu}/^{177}\text{Hf}$ was 0.000293 ± 32 (2SD, n=32,
346 defining an excess variance of 10.0%, which was used in uncertainty propagation for
347 zircon samples). After normalization to 91500 and full uncertainty propagation, Mud Tank
348 (z1) validation results were $^{176}\text{Hf}/^{177}\text{Hf} = 0.282492 \pm 9$ (MSWD 1.4, n=13) and $^{176}\text{Lu}/^{177}\text{Hf}$
349 $= 0.000105 \pm 3$ (MSWD 0.66, n=13).

350

351 3.2 Low-volume laser ablation analyses

352

353 *3.2.1 U-Pb*

354 A 5% discordance filter was applied to the laser ablation U-Pb analyses and the
355 data for 77 analyses of sample Zimb-95-24 are presented in Table 5. The data point
356 uncertainties range from 1.2 to 4.0 (% 2σ) for the $^{206}\text{Pb}/^{238}\text{U}$ ages of the zircons and 0.2
357 to 22 (% 2σ) for the $^{207}\text{Pb}/^{206}\text{Pb}$ ages of the zircons. The higher $^{207}\text{Pb}/^{206}\text{Pb}$ uncertainties
358 mostly arise when determining low-Pb samples on the ion-counter-Faraday ^{207}Pb - ^{206}Pb
359 configuration. Figure 4a demonstrates the ^{238}U - ^{206}Pb and $^{207}\text{Pb}/^{206}\text{Pb}$ age precision
360 obtained for these 10 second analyses as a function of U concentration, indicating little
361 compromise in the achievable uncertainty compared to more conventional ablation
362 approaches. Validation data for secondary reference materials (91500 and Plešovice
363 zircon) were normalized to GJ-1, the primary reference material, and are presented in
364 Supplementary Table 4 and Supplementary Figure 2a-b.

365

366 *3.2.2 Lu-Hf*

367 A summary of the laser ablation zircon Lu-Hf isotopic data for U-Pb discordance-
368 filtered analyses (<5%) of detrital sample Zimb-95-24 is presented in Table 5 with all data
369 provided in Supplementary Table 5. Figure 4b highlights the $^{176}\text{Hf}/^{177}\text{Hf}$ measurement
370 precision (2SE%) in relation to Yb/Hf, demonstrating that the uncertainty does not
371 correlate strongly with the size of the correction and that a <1 epsilon uncertainty is mostly
372 still attained despite sampling only ~0.3 ng Hf. The $^{176}\text{Lu}/^{177}\text{Hf}$ of the samples ranges
373 between 0.000007 and 0.001398. Uncertainties of the $^{176}\text{Hf}/^{177}\text{Hf}$ range from 0.7 to 1.1
374 ϵ_{Hf} . Before normalization, the $^{176}\text{Hf}/^{177}\text{Hf}$ of the primary reference material, zircon 91500,
375 was 0.282298 ± 4 (0.0014%, MSWD = 1.5, n=75) and $^{176}\text{Lu}/^{177}\text{Hf}$ was 0.000319 ± 18
376 (2SD, n=75, defining an excess variance of 5.7%, which was used in uncertainty
377 propagation for Zimb-95-24 zircons). After normalization to 91500 including uncertainty
378 propagation for excess variance (especially in Lu/Hf), Mud Tank validation results were
379 0.282514 ± 4 ($^{176}\text{Hf}/^{177}\text{Hf}$, 0.0014% 2s, MSWD=2.3, n=55) and 0.000084 ± 1 ($^{176}\text{Lu}/^{177}\text{Hf}$,
380 1.2% 2s, MSWD=0.3, n=55). Plešovice validation results were 0.282483 ± 4 ($^{176}\text{Hf}/^{177}\text{Hf}$,
381 0.0014% 2s, MSWD=0.8, n=54) and 0.000099 ± 1 ($^{176}\text{Lu}/^{177}\text{Hf}$, 1.0% 2s, MSWD=15,
382 n=54).

383

384 4. Discussion

385

386 4.1 The necessity of chemical separation of Hf from zircon solutions

387 The majority of zircon Lu-Hf analysis methods have been influenced by whole rock
388 ICP-MS procedures, which require chemical separation of Hf from potential interferants
389 Lu and Yb as well as from Zr, which is thought to influence Hf ionization in the plasma
390 (Barovich et al., 1995; Blichert-Toft et al., 1997; Corfu et al., 1992; Münker et al., 2001;
391 Peters et al., 2015). Some studies present zircon Lu-Hf isotopic data in which the samples
392 were subject to separation of HREEs and/or Zr from Hf in preparation for ICP-MS analysis
393 (e.g. Amelin et al., 1999; Iizuka et al., 2015) while others have run zircon solutions 'neat'
394 (e.g. Davis et al., 2005; Schoene et al., 2012; d'Abzac et al., 2016). Because chemical
395 separation takes time, introduces additional blank, and necessitates the removal of an
396 aliquot before chemical separation to measure the $^{176}\text{Lu}/^{177}\text{Hf}$ of the sample, thereby
397 restricting the efficiency of the Hf isotope determination for small samples, we compared

398 the results of running zircon 91500 neat to those subjected to HREE and Zr separation
399 chemistry to determine the acceptability of analyzing neat solutions.

400 In order to verify that neat solutions would be viable to analyze in this way, potential
401 discrepancies in $^{176}\text{Hf}/^{177}\text{Hf}$, $^{178}\text{Hf}/^{177}\text{Hf}$, and $^{180}\text{Hf}/^{177}\text{Hf}$ between separated and neat
402 91500 solutions were investigated (Fig. 5, Supplementary Fig. 3). Figure 5 shows the
403 $^{176}\text{Hf}/^{177}\text{Hf}$ results for 91500 analyzed at varying concentrations during this study, using
404 purified Hf or neat solutions. The $^{176}\text{Hf}/^{177}\text{Hf}$ weighted means of the two analysis types
405 (subdivided by Hf concentration) are indistinguishable. The weighted mean $^{176}\text{Hf}/^{177}\text{Hf}$,
406 $^{178}\text{Hf}/^{177}\text{Hf}$, and $^{180}\text{Hf}/^{177}\text{Hf}$ of these subpopulations are compiled in Supplementary Figure
407 3. The nonradiogenic $^{178}\text{Hf}/^{177}\text{Hf}$ and $^{180}\text{Hf}/^{177}\text{Hf}$ isotope ratios are monitors of data quality.
408 Additionally, Figure 3b-c demonstrate that these methods return acceptable values and
409 uncertainties for the natural samples, with the exception of $^{180}\text{Hf}/^{177}\text{Hf}$ extending to higher
410 values for the smallest samples (<0.2 ng Hf; Fig. 3b). Since the $^{178}\text{Hf}/^{177}\text{Hf}$ remains stable,
411 this may imply a relationship with a ^{90}Zr dimer at low total Hf, and therefore we have
412 selected a lower limit analytical cut-off at 0.3 ng Hf. The introduction of Zr into the plasma
413 during solution analysis (with an assumed Zr/Hf ~50, the natural samples in this study
414 contained between 5 and 200 ng of Zr) has not made an observable impact on the
415 $^{176}\text{Hf}/^{177}\text{Hf}$ measurement. This was also the observation and conclusion of d'Abzac et al.
416 (2016).

417 The equivalence of Hf isotopic ratios of the two analysis types (neat and separated)
418 demonstrates that, at the chosen run amounts (0.1-4.1 ng Hf) under low oxide (and thus
419 more robust) plasma conditions, there is no significant benefit to chemical separation of
420 Hf. Furthermore, the level of precision achieved in either case is equivalent to precision
421 obtained with conventional methods on sample amounts 10 times greater, so the
422 equivalence of these ratios is not attributable to loss of analytical resolution (i.e. large
423 uncertainties). The analysis of neat solutions maximizes the total Hf yield, which would
424 be compromised during a separated solution procedure by Hf separation efficiency as
425 well as by the removal of an aliquot for Lu/Hf measurement. Additionally, we found it
426 difficult to achieve a clean Zr-Hf separation, as our method requires >150 column volumes
427 of eluting acid to bring the Zr/Hf of the Hf elution step down from 50 to <5 (Supplementary
428 Table 1 for method). Furthermore, incomplete separation of Hf from Lu and Yb results in

429 a problematic correction for these interferants because it is difficult to accurately measure
430 small ion beams, yet the Yb and Lu beams will still represent significant interferences on
431 the 176 mass. The analysis of neat solutions has not resulted in an apparent bias in our
432 Hf isotopic results and this approach enables the simultaneous determination of Hf
433 isotopic and $^{176}\text{Lu}/^{177}\text{Hf}$ composition. For these reasons, the analysis of neat dissolved
434 zircon solutions is the most efficient method for Lu-Hf isotope analysis, particularly for
435 studies concerned with minimizing sampling volume.

436

437 4.2 Yb correction methods for solution and laser ablation Hf isotope analysis

438 The data described in this study largely show mutual agreement between
439 $^{176}\text{Hf}/^{177}\text{Hf}$ calculated using an Yb correction derived by measuring the Yb mass bias
440 compared to the Yb correction derived through precalibration of the $^{176}\text{Yb}/^{173}\text{Yb}$ using the
441 Hf mass bias. This agreement is demonstrated for the laser ablation analyses of the
442 Zimbabwe sample (Fig. 6a) as well as the analyses of granitic and variably Yb-doped
443 Mud Tank zircon solutions (Fig. 6b, Fig. 7a). However, a detailed examination of the
444 solution data (Fig. 6b, Fig. 7a) highlights a small discrepancy. The samples generally
445 correspond to a 1:1 line, indicating agreement between the two Yb-correction methods
446 (Fig. 6b), however, there is a minor bias that is more pronounced for samples with high
447 Yb/Hf (see color key in Fig. 6b). In almost all cases, this bias is within uncertainty of the
448 1:1 line, and therefore is not interpreted to be significant. With respect to the Yb-doped
449 Mud Tank results, the Yb solution used did not have an unnatural Yb isotopic composition,
450 nor did it contain Hf. The $^{180}\text{Hf}/^{177}\text{Hf}$ and $^{178}\text{Hf}/^{177}\text{Hf}$ of these analyses do not exhibit any
451 trends with level of Yb dopant or with $^{176}\text{Hf}/^{177}\text{Hf}$ (Supplementary Figure 4). These
452 solutions were doped to higher Yb/Hf than most terrestrial zircons, and the Yb/Hf of the
453 natural samples of this study were at the highest end of the range for natural zircons.
454 Therefore, the behavior exhibited is for relatively extreme examples. The Yb correction
455 derived from the direct measurement of Yb mass bias under-corrects the ^{176}Yb isobar
456 (using the accepted value of $^{176}\text{Hf}/^{177}\text{Hf}$ for Mud Tank zircon, 0.282507 ± 3 ; Woodhead
457 and Hergt, 2005), and this scales to a higher degree of undercorrection for aliquots with
458 larger Yb/Hf. The $^{176}\text{Hf}/^{177}\text{Hf}$ results determined by pre-calibrating the mass bias
459 relationships between Yb and Hf are accurate to $\pm 0.7 \epsilon_{\text{Hf}}$ units, suggesting that the pre-

460 calibration method of Yb correction is more reliable for our work. At this time, the cause
461 of this bias for the Yb-corrected data using the measured Yb ratio is unknown. Despite
462 the high REE levels indicated by the Yb/Hf of the solution samples (Fig. 6b), it is not
463 anticipated that this bias is related to MREE oxides as indicated by Payne et al. (2013),
464 due to the maintenance of low-oxide conditions in our analytical set-up. More importantly,
465 the Mud Tank experiments used an Yb dopant only—MREE therefore did not vary
466 between the analyses, which were all run at the same matrix concentration, and the
467 similarity in scale of bias for the solution samples and the Mud Tank experiments suggests
468 there must be another cause. Figure 7b and 7c demonstrate the degree of bias between
469 the two Yb correction methods relative to the amount of Yb present. Generally, solutions
470 with higher [Yb] exhibited a larger degree of bias between the two methods of Yb
471 correction. Additionally, Figure 8 demonstrates that the pre-calibrated Yb correction using
472 Hf mass bias is more precise at REE concentrations too low for Yb to be accurately
473 measured on a Faraday collector ($<0.01 \text{ V } ^{173}\text{Yb}$). For all of these reasons, the data
474 presented was corrected by the pre-calibration method.

475 The nature of the offset may be the result of non-mass dependent fractionation of
476 Yb in the plasma, much like has been recorded for the Nd isotopic system (Newman et
477 al., 2009). If that were the case, the expected offset would be the largest for analyses with
478 the highest [Yb] that were corrected with directly-measured Yb isotopic ratios, which is
479 consistent with our results (Fig. 7c).

480 One laser ablation datum deviates significantly from the 1:1 line in Figure 6a; this
481 is for a zircon (which is 13% discordant and would therefore normally be excluded on the
482 basis of discordance filtering, see note in Table 5) for which the $^{176}\text{Yb}/^{177}\text{Hf}$ (~ 0.27) is
483 unusually high and outside the range encompassed by most natural zircons (see Figure
484 1 of Fisher et al., 2011). While MREE oxides could produce this effect (Payne et al., 2013),
485 our maintenance of low oxide tuning conditions should mitigate the influence of MREEs
486 and our Yb-doped Mud Tank and granitic zircon solution results suggest another cause
487 is more likely. The highest level of admixed Yb dopant of our Mud Tank analyses was
488 targeted to be comparable to the Yb level in this aberrant laser ablation analysis and yet
489 the degree of bias is 3 times greater (9 vs 3 epsilon Hf units, see Figures 6a and 7a).
490 Since an adjacent ablation on the same zircon crystal yielded a much lower degree of Yb

491 enrichment and agreement between the two Yb correction methods, a reasonable
492 explanation may be that inadvertent ablation of an inclusion or an altered domain affected
493 the analysis.

494 Since both methods of Yb correction generally return equivalent values, we
495 suggest that both results be considered for quality control of zircon laser ablation Lu-Hf
496 isotopic data. Final data can be reported using the Yb correction pre-calibrated for the
497 Yb-Hf mass bias relationship, but lack of agreement with data corrected using the
498 measured Yb ratio will highlight potentially problematic data which can be further
499 scrutinized and excluded from final interpretation as appropriate.

500

501 4.3 Lu-Hf uncertainty & age correction

502 The initial Hf isotopic signature is of interest for most zircon Lu-Hf studies, and the
503 $^{176}\text{Lu}/^{177}\text{Hf}$ is a necessary component of its calculation. Because the $^{176}\text{Lu}/^{177}\text{Hf}$ of zircon
504 is $\ll 1$ and the decay rate of ^{176}Lu is slow relative to the timescale of terrestrial processes,
505 the amount of radiogenic ingrowth for most terrestrial zircon grains is of minor enough
506 magnitude that the $^{176}\text{Lu}/^{177}\text{Hf}$ uncertainty is a negligible component of initial Hf
507 uncertainty (see Fig. 9, with a $\pm 10\%$ variation in $^{176}\text{Lu}/^{177}\text{Hf}$ uncertainty expressed as a
508 20% variation). However, sub-nanogram Hf isotopic analyses will contain femto to sub-
509 picogram amounts of Lu, making precise measurement difficult and therefore the
510 $^{176}\text{Lu}/^{177}\text{Hf}$ uncertainty must be properly accounted for. Our goals for Lu/Hf determinations
511 thus included an evaluation of reproducibility of solution $^{176}\text{Lu}/^{177}\text{Hf}$, something that has
512 not been addressed in other small-volume Lu-Hf studies, in part to confirm that the
513 uncertainty of the age-corrected Hf isotopic signature would not be appreciably affected
514 by the level of precision maintained for analyses of just $\sim 30\text{-}40$ ng of zircon.

515 Neat Mud Tank and 91500 zircon solutions were doped with Lu to evaluate
516 variation in $^{176}\text{Lu}/^{177}\text{Hf}$ resulting from the concentration of zircon matrix, as well as at
517 varying levels of Lu/Hf for the same matrix concentration. We were able to resolve a
518 matrix-related bias, approximated by relating the concentration of Hf in the sample and
519 the resultant $^{176}\text{Lu}/^{177}\text{Hf}$ for solutions run with 0.5, 1.0, and 2.0 ng Hf. The total matrix-
520 related bias for neat Mud Tank and 91500 zircon solutions doped to $\text{Lu}/\text{Hf} \sim 0.0007$ show
521 an approximate -0.2% shift in $^{176}\text{Lu}/^{177}\text{Hf}$ per ppb Hf in the sample solution

522 (Supplementary Fig. 5). Following normalization to the reference material, a correction
523 was applied to the $^{176}\text{Lu}/^{177}\text{Hf}$ sample results to account for this matrix bias.

524 The determination of $^{176}\text{Lu}/^{177}\text{Hf}$ uncertainty was a multi-stage process. The excess
525 variance of the session reference material, 91500, was added to our standard-corrected
526 $^{176}\text{Lu}/^{177}\text{Hf}$ uncertainties. This was done according to sample concentrations; samples run
527 with subnanogram Hf amounts were corrected with 91500 run at 0.3 ng per analysis (3
528 ppb solution, 0.0042% 1s) and samples containing nanograms of Hf were corrected with
529 91500 run at 2.0 ng per analysis (20 ppb solution, 0.03- 0.11% 1s). A low-concentration
530 reference material was used to determine session excess variance because it is most
531 representative of the sample sizes evaluated. Next, an excess uncertainty related to the
532 Lu concentration was determined. To do this, the long-term excess variance of 0.5, 1.0,
533 and 2.0 ng neat analyses of 91500 were calculated to derive a simple relation between
534 the Lu concentration and excess variance of 91500. This was applied as a propagation
535 to the sample $^{176}\text{Lu}/^{177}\text{Hf}$ uncertainty, in quadrature. Finally, the long-term excess
536 uncertainty for the entire analytical program was determined (0.013% 1s for 20 ppb Hf
537 solution and 1.25% for 3 ppb Hf) and applied. The resulting $^{176}\text{Lu}/^{177}\text{Hf}$ uncertainties of
538 the zircon samples were commonly ~2.5-3% for ≥ 0.3 ng Hf analyses, with a few outliers
539 with uncertainties as high as ~6-13% for 0.1 ng Hf analyses. This level of $^{176}\text{Lu}/^{177}\text{Hf}$
540 uncertainty will comprise a negligible component of initial ϵ_{Hf} uncertainty for the vast
541 majority of terrestrial applications but is significant for determining accurate age-corrected
542 Hf signatures of Archaean and Hadean zircons (Fig. 9).

543

544 4.4 Importance of tuning the instrument for low oxides

545 In MC-ICP-MS isotope studies, the analytical set-up is usually optimized for
546 maximum ion transmission. On a ThermoScientific Neptune Plus, this includes the
547 addition of a Jet sample cone and an X skimmer cone. However, the resultant signal
548 maximization also promotes increased oxide formation in the plasma and generally
549 results in increased sensitivity to matrix composition and plasma loading, production of
550 polyatomic interferences, and space-charge repulsion in the plasma. Payne et al. (2013)
551 demonstrated the need for quantification of REE oxide production in plasmas in such
552 cases. The production of oxides is problematic for several reasons. First of all, different

553 elements form oxides at different rates, resulting in inter-element fractionation. Accurate
554 Lu/Hf is necessary for the determination of Hf isotopic data corrected for age and
555 therefore maintenance of low oxide conditions is critical. There are multiple REE oxides
556 that directly interfere with masses of interest for Lu-Hf isotopic measurements, including
557 those masses utilized for isobaric interference corrections. In particular, Gd and Dy oxides
558 interfere with Yb and Hf mass bias corrections, resulting in spurious Hf isotope ratios at
559 modest oxide levels (Payne et al., 2013) and/or for solutions with high concentrations of
560 REEs (d'Abzac et al., 2016).

561 The possible impact of Gd and Dy oxide formation on the results presented here
562 may be inferred using the relative values of oxide production of these elements to HfO^+ .
563 Payne et al (2013) demonstrated that the GdO^+ formation rate is ~3 times greater than
564 the formation rate of HfO^+ , when using desolvated solution methods. Of the various
565 analytical sessions in our study, the rate of HfO^+ formation was <0.05% and was as low
566 as 0.007%. This would suggest GdO^+ production rates of ~0.02-0.15% which, for the
567 range of Yb/Hf compositions determined in this study, could result in a bias to higher
568 epsilon Hf values by 0 – 0.8 epsilon units, but will be partly reduced by the complex
569 interplay of the interference mass spectrum on the Yb correction. For the most part, this
570 level of bias is well within the determined uncertainty range of our data and the agreement
571 between the two cited methods of Yb correction would suggest that it is insignificant. The
572 formation of MREE oxides therefore does not appear to have had a significant effect on
573 the results under the run conditions described here. However, the role of MREE oxides
574 with respect to the accuracy of interference corrections in zircon Hf isotope
575 determinations should be considered when dealing with high-REE/Hf zircons.

576

577 4.5 Minimization of sampling volume during solution analysis and laser ablation

578 The lower limit of Hf required for solution analyses run with our methods is about
579 0.3 ng. Below this limit, the $^{180}\text{Hf}/^{177}\text{Hf}$ values diverge from the expected value (Fig. 3b)
580 and the precision of the $^{176}\text{Hf}/^{177}\text{Hf}$ measurement exceeds 1 epsilon unit (Fig. 3a), a limit
581 considered appropriate for most applications. 0.3 ng Hf equates to approximately 30 ng
582 of zircon. For sessions with the highest detection efficiency, ~1 epsilon unit precision was
583 achieved using only 0.2 ng Hf (~20 ng zircon). Running solution samples pre-

584 concentrated in 100 μl of liquid using a modified sample introduction protocol has
585 therefore successfully increased the signal-to-noise ratio of the analysis and enabled
586 shorter analysis durations, while maintaining precision.

587 Multiple analytical protocols were tested for laser ablation analyses to minimize the
588 volume of zircon analyzed for the U-Pb and Lu-Hf systems. This resulted in a range of pit
589 morphologies. To quantify the amount of material excavated with each type of analysis,
590 a SEM was used to image and calculate the depth of the pits. Although the geometry of
591 the pits is variable, we assume that they are perfectly cylindrical and calculate the volume
592 of the pits using the maximum depth measured, and calculate the total mass of zircon
593 ablated. Pit depths and estimates of maximum volume of ablated material are presented
594 (Supplementary Table 6) for a variety of U-Pb spots as well as for Lu-Hf spots overlapping
595 U-Pb spots (Fig. 2 for pit images). The 10-second Hf analyses ablated $<16\ \mu\text{m}$ deep,
596 consuming around 40 ng of zircon. Ideally, a total ablation pit depth of 10 μm or less for
597 both U-Pb and Hf analyses would increase the likelihood that a different age zone had
598 not been penetrated during the Hf analysis. The time-resolved data reduction allowed for
599 verification that only a single zone of Hf isotopic composition had been sampled (within
600 the resolution of the data). Considering only the first half of each analysis therefore allows
601 an assessment of the uncertainty achievable on a five second, $<8\ \mu\text{m}$ deep analysis
602 consuming just 20 ng zircon. The highest uncertainty of the five-second analyses is ~ 2
603 epsilon Hf (Fig. 10). The $^{176}\text{Lu}/^{177}\text{Hf}$ uncertainties did not change appreciably. Therefore,
604 the utility of analyses sampling just 8 μm deep in a five-second analysis depends on the
605 degree of uncertainty acceptable for the considered geologic application and the nature
606 of the sample (e.g. length scale and degree of zonation, detrital or non detrital). It is
607 therefore feasible to subsample small volumes of zircon material, permitting combined
608 Lu-Hf and U-Pb analysis of individual growth zones at a fine scale ($\sim 10\ \mu\text{m}$). These small-
609 volume Hf laser ablation analyses could be coupled with U-Pb single pulse methods (e.g.
610 Cottle et al., 2009) to result in ablation amounts of just ~ 18 ng of zircon (25 μm spot, 8
611 μm deep) for combined Lu-Hf and U-Pb isotopic information. Although there is then
612 disparity between the volumes upon which the U-Pb and Lu-Hf information have been
613 determined, it is reasonable to assume homogeneity at the 10-20 μm level and
614 heterogeneity can still be detected using time-resolved analysis data processing,

615 discarding the data point if necessary. It is notable that for analyses of 30-40 ng zircon,
616 solution and laser ablation analyses resulted in the same uncertainties (Fig. 11) and that
617 it is possible to handle and determine such small amounts of zircon by solution methods.
618

619 4.6 Moving forward with low-volume Lu-Hf analyses

620 The focus of this study is low-volume coupled Lu-Hf and U-Pb isotope analysis of
621 zircon. The Lu-Hf solution method employed, namely the introduction of small amounts
622 of material either manually or via the Cetac MVX-7100, is translatable to other minerals
623 and isotope systems. Instead of focusing on the subdivision of complexly-zoned, high-
624 [Hf] minerals such as zircon (or small baddeleyites, as in d'Abzac et al., 2016), our
625 solution method can be applied to lower-[Hf] samples, such as bulk meteorite splits (e.g.
626 Bast et al., 2015). In combination with a host of other analytical improvements, e.g. Jet
627 sample cones and 10^{12} ohm resistors, the increase in SNR brought about by running 100
628 μL volumes and by quantifying blank size and its isotopic composition will facilitate
629 measurement of smaller amounts of material at higher precision than previously
630 managed. This will enable sampling of complex samples at a higher spatial resolution,
631 including meteorites, whole rocks, garnet, and other minerals.

632 The most critical work for advancing low-volume zircon Lu-Hf studies via laser or
633 solution methods will be technique development that increases Hf efficiency while
634 maintaining low levels of oxide production. Beyond the consideration of the elements that
635 are typically of interest (Hf, Lu, and Yb) in these studies when monitoring oxide formation,
636 it is also advisable to monitor the levels of production of Gd and Dy oxides because these
637 will impact the Yb and Hf mass biases, respectively. The formation of these oxides can
638 be documented at the beginning and end of an analytical session using Gd, Dy- doped
639 JMC475 Hf solutions. Additionally, synthetic zircons variably doped with REEs (MUNzirc;
640 Fisher et al., 2011) can be used to monitor oxide production throughout an LA-ICP-MS
641 session. The synthetic MUNzirc zircons are widely used in laboratories performing Lu-Hf
642 laser ablation analyses.

643 The low-oxide production, high analyte efficiency approach in this study is also
644 transferable to isotope systems other than Lu-Hf, particularly in cases for which oxide
645 production levels must remain low, most notably for the Sm-Nd isotope system.

646 Additionally, the laser ablation methods of this study result in improved high-resolution
647 sampling of zoned zircons, with combined U-Pb and Lu-Hf ablation amounts as low as 30
648 ng of zircon. The coupling of five-second Lu-Hf ablations with single pulse U-Pb work
649 (Cottle et al., 2009), resulting in 25 μm spots 8 μm deep, will result in finer-scale coupled
650 zircon analyses, something which is not achievable with conventional methods.

651

652 **5. Conclusions**

653 In this study, methods are established for coupled Lu-Hf and U-Pb isotope
654 analyses of zircon, focusing on low-volume solution and laser ablation methods
655 corresponding to 20-40 nanograms of zircon. These techniques enable the analysis of
656 complex zircons in cases where age zonation could easily result in the decoupling of U-
657 Pb and Lu-Hf isotope information, potentially producing spurious initial Hf isotopic results.
658 Our reduced-volume laser ablation protocol provides an alternative to split-stream
659 analysis and consumes less zircon. Consecutive U-Pb and Lu-Hf isotopic analyses are
660 utilized and result in a total spot size and pit depth of 25 and 18 μm , respectively, thereby
661 excavating just ~ 40 ng of zircon. We demonstrate that by integrating only part of the Hf
662 isotope data, appropriate levels of uncertainty can be obtained on just ~ 20 ng total of
663 ablated zircon. For our solution measurements, sample introduction protocols were
664 optimized to consume just 100 μL of solution, resulting in a 10-fold decrease in required
665 sample size over conventional approaches. This was achieved with comparable levels of
666 uncertainty and total sample volume as measured by laser ablation, using just 0.3-0.4 ng
667 of Hf while achieving uncertainties $\sim 1 \epsilon_{\text{Hf}}$. These solution measurements can be
668 conducted either manually or automatically, allowing for this method to become routine.
669 By optimizing for low levels of oxide production instead of maximizing Hf detection
670 efficiency, we conclude that Yb correction methods of neat zircon washes determined
671 using either direct measurement of Yb mass bias or by pre-calibration of Yb mass bias to
672 Hf mass bias are both suitable, with the latter approach providing more accurate data for
673 high Yb/Hf samples. $^{176}\text{Lu}/^{177}\text{Hf}$ can also be accurately determined during the same
674 sample analysis, increasing efficiency compared to conventional solution analysis
675 approaches. Solution and laser ablation methods are demonstrated to utilize equivalent
676 amounts of material, achieving the same uncertainty level ($\sim 1 \epsilon_{\text{Hf}}$) necessary for resolving

677 complexity on the scale of 10-20 microns and therefore can yield meaningful results for
678 complex zircons.

679

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689

690 Figure Captions

691

692 Figure 1. Representative CL images of Zimb-95-24 zircons with ablation spots (orange
693 circles) or box rasters (orange squares) indicated. All scale bars are 100 μm .

694

695 Figure 2. SEM images of different laser ablation spot types of this study; scale bars are
696 20 μm and all analyses consisted of about 10 seconds of ablation. a) U-Pb analysis pit
697 with a 25 μm spot and a 2.7 J/cm^2 fluence; b) U-Pb analysis pit with a 15 μm spot and a
698 2.7 J/cm^2 fluence; c) U-Pb analysis box raster with a 10 μm spot and a fluence of 3.2
699 J/cm^2 ; d) Lu-Hf analysis pit with a 25 μm spot and 6.5 J/cm^2 fluence.

700

701 Figure 3. For zircon solution analyses in this study, the relationship between the
702 approximate nanograms of Hf analyzed and: a) measurement uncertainty (in epsilon Hf
703 units, excluding propagation for systematic and excess uncertainty); b) $^{180}\text{Hf}/^{177}\text{Hf}$; and c)
704 $^{178}\text{Hf}/^{177}\text{Hf}$. The shift in $^{180}\text{Hf}/^{177}\text{Hf}$ at lower Hf concentration motivates our lower limit cut-
705 off of 0.3 ng Hf, which is indicated by the dashed gray line (see Sections 4.1 and 4.5).
706 Analyses are color-coded by analytical session to demonstrate the shift in analytical
707 uncertainty under different tuning conditions.

708

709 Figure 4. Precision of laser ablation analyses of natural sample Zimb-95-24, for: a) U-Pb
710 dates as a function of U concentration, indicating little compromise in the measured
711 uncertainty compared to more conventional ablation approaches; and b) $^{176}\text{Hf}/^{177}\text{Hf}$ as a
712 function of Yb/Hf, demonstrating that the uncertainty is not a function of the magnitude of
713 correction of the Yb interference. In part b, epsilon Hf units are indicated with horizontal
714 lines and black symbols represent the 2SE% of the analyses while the gray symbols
715 represent full systematic uncertainty propagation (2S%).

716

717 Figure 5. Interference- and mass bias-corrected $^{176}\text{Hf}/^{177}\text{Hf}$ results for zircon reference
718 material 91500 during this study, demonstrating that the results are indistinguishable for
719 zircon solutions with and without separation of isobaric interferences. Neat solutions are
720 indicated by gray symbols and solutions that underwent Hf-HREE separation chemistry
721 are indicated by white symbols. Symbol shape denotes Hf concentration of analysis. The
722 weighted average, 2SE, and MSWD of each population are listed. The Yb interference
723 correction was empirically-derived with $^{176}\text{Yb}/^{173}\text{Yb} = 0.79435\text{-}0.79455$, depending on the
724 session.

725

726 Figure 6. Comparison of $^{176}\text{Hf}/^{177}\text{Hf}$ results using two different Yb correction methods (x-
727 axis: calibrated to standards and Hf mass bias, and y-axis: by directly measuring the
728 $^{173}\text{Yb}/^{172}\text{Yb}$ of the solution). A 1:1 line is plotted for reference and the color of analysis
729 symbols is scaled for $^{176}\text{Yb}/^{177}\text{Hf}$ (color bar, at right). The majority of the samples conform
730 to a 1:1 relationship; which validates both Yb correction methods. In a), the exception is
731 a zircon spot analysis with unusually high $^{176}\text{Yb}/^{177}\text{Hf}$, which is discussed in the text.

732

733 Figure 7. a) Comparison of two methods of Yb correction for analyses of 20 ppb Hf Mud
734 Tank zircon with variable amounts of admixed Yb above natural Yb levels ($^{176}\text{Yb}/^{177}\text{Hf}$
735 ~ 0.0004) in Mud Tank. A stock solution of one zircon dissolution was used for these
736 analyses. The isotopic variability following each Yb correction method is of greater
737 magnitude for higher Yb beams. A 1:1 line is plotted for reference. The accepted value is
738 0.282507 ± 3 and is indicated by a gray box (Woodhead and Hergt, 2005). b) The deviation

739 from the accepted value for Mud Tank zircon of Yb-corrected $^{176}\text{Hf}/^{177}\text{Hf}$ resulting from Yb
740 correction with measured Yb (square symbols) and from Yb correction using
741 precalibration of the Hf mass bias (circle symbols), plotted against Yb signal of Yb-doped
742 Mud Tank solutions. c) The difference between $^{176}\text{Hf}/^{177}\text{Hf}$ results using the two Yb
743 correction methods plotted against measured Yb signal (V), indicating an increase in the
744 difference between the two methods with increasing Yb concentration.

745

746 Figure 8. Uncertainty in $^{176}\text{Hf}/^{177}\text{Hf}$ resulting from Yb correction using measured Yb
747 (square symbols) versus precalibration using Hf mass bias (circle symbols), plotted
748 against measured Yb beam (V) (for analyses with $<0.04 \text{ V } ^{173}\text{Yb}$) of Yb-doped JMC
749 solutions as well as neat and variably Yb-doped zircon 91500 and Mud Tank solutions of
750 this study.

751

752 Figure 9. Effect of 20% variation of measured $^{176}\text{Lu}/^{177}\text{Hf}$ of zircons of varying age (0.5,
753 1.0, 2.5, and 4.0 Ga). If the $^{176}\text{Lu}/^{177}\text{Hf}$ is mismeasured by 20%, the absolute shift in
754 epsilon Hf will be about 0.6 epsilon units for most 4 Ga zircons but will be within analytical
755 uncertainty for most zircons younger than about 2.5 Ga. This illustrates that the age
756 correction for Hf ingrowth matters most for Archean and Hadean zircons that have
757 relatively high HREE/Hf.

758

759 Figure 10. Comparison of laser ablation results for a) $^{176}\text{Hf}/^{177}\text{Hf}$ uncertainties and b)
760 $^{176}\text{Lu}/^{177}\text{Hf}$ uncertainties of 10 and 5 second integrations of the same analysis.

761

762 Figure 11. The relationship between measurement uncertainty (in epsilon Hf units) and
763 the approximate total nanograms of Hf analyzed in laser ablation analyses (black circles)
764 of Zimb-95-24 zircons and zircon reference materials (assuming 35 ng of zircon ablated
765 and Hf concentrations normalized relative to $\sim 0.64 \text{ Hf wt\%}$ of zircon 91500; Belousova et
766 al., 2002). The gray field in the background is from solution analysis of granitic zircons in
767 this study (Fig. 3a). The degree of uncertainty is comparable for solution and laser
768 ablation methods.

769

770 Supplementary Figure 1. Schematic showing how pit depths were calculated. The sample
771 stage was tilted to 40 degrees and therefore the true depth is equal to the apparent depth
772 divided by sine of 40 degrees (m =apparent depth, d =true depth).

773

774 Supplementary Figure 2a. Validation results of secondary reference material zircon
775 91500 for laser ablation analyses. The analysis spot type is denoted in each plot. The
776 accepted $^{207}\text{Pb}/^{206}\text{Pb}$ age for this sample is 1065.4 ± 0.3 Ma (Wiedenbeck et al., 1995).

777

778 Supplementary Figure 2b. Validation results of secondary reference material zircon
779 Plešovice for laser ablation analyses. The analysis spot type is denoted in each plot.
780 Configurations A and B refer to collection schemes in Table 3. The accepted $^{206}\text{Pb}/^{238}\text{U}$
781 age of this sample is 337.13 ± 0.37 Ma (Sláma et al., 2008).

782

783 Supplementary Figure 2c. Lu-Hf laser ablation validation results of secondary zircon
784 reference materials Mud Tank and Plešovice. The weighted means are within uncertainty
785 of the accepted compositions (Woodhead and Hergt, 2005; Sláma et al., 2008),
786 $^{176}\text{Hf}/^{177}\text{Hf} = 0.282514 \pm 5$ (Mud Tank zircon; MSWD 2.3, $n=55$) and $^{176}\text{Hf}/^{177}\text{Hf} =$
787 0.282484 ± 4 (Plešovice; MSWD 1.7, $n=54$).

788

789 Supplementary Figure 3. Weighted mean mass bias-corrected $^{176}\text{Hf}/^{177}\text{Hf}$, $^{178}\text{Hf}/^{177}\text{Hf}$ and
790 $^{180}\text{Hf}/^{177}\text{Hf}$ results of zircon reference material 91500 run at 40, 20, and 3 ppb Hf. Symbol
791 shape denotes Hf concentration of analysis. Neat solutions are indicated by gray symbols
792 and solutions that underwent Hf-HREE separation chemistry are indicated by white
793 symbols. There are no significant differences in the measured $^{176}\text{Hf}/^{177}\text{Hf}$, $^{178}\text{Hf}/^{177}\text{Hf}$ and
794 $^{180}\text{Hf}/^{177}\text{Hf}$ of purified zircon Hf and neat solutions.

795

796 Supplementary Figure 4. $^{180}\text{Hf}/^{177}\text{Hf}$ versus $^{178}\text{Hf}/^{177}\text{Hf}$ of Mud Tank solution analyses.
797 Symbol color corresponds to concentration of Yb as in Figure 7.

798

799 Supplementary Figure 5. Regression of $^{176}\text{Lu}/^{177}\text{Hf}$ versus ppb Hf for a) Lu-doped 91500
800 solution; b) Lu-doped Mud Tank solution; and c) undoped 91500 solution analyses; all of

801 which document a shift of ~0.2% per ppb Hf in the analysis solution. In c, the 91500
802 solutions analyzed at varying concentration are self-normalized to the 20 ppb
803 concentration analyses.

804
805

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807

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